

<b>Notice of References Cited</b>	Application/Control No. 09/219,195	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Franklin D. Altman	Art Unit 2652	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number	Date	Name	Classification	
		Country Code-Number-Kind Code	MM-YYYY			
	A	US-5,337,202-	08-1994	Jabbari	360	97.01
	B	US-6,069,774-	05-2000	Arisaka et al	360	245.3
	C	US-6,002,550-	12-1999	Amemiya	360	234.5
	D	US-4,737,872-	04-1988	Delacou	360	281.7
	E	US-5,943,189-	08-1999	Boutaghou et al	360	234.7
	F	US-5,717,547-	02-1998	Young	360	246
	G	US-5,781,380-	07-1998	Berding et al	360	264.2
	H	US-5,657,186-	08-1997	Kudo et al	360	234.5
	I	US-6,181,531-B1	01-2001	Koshikawa et al	360	294.4
	J	US-6,122,149-	09-2000	Zhang et al	360	294.5
	K	US-6,078,473-	06-2000	Crane et al	360	294.3
	L	US- -				
	M	US- -				

**FOREIGN PATENT DOCUMENTS**

*		Document Number	Date	Country	Name	Classification	
		Country Code-Number-Kind Code	MM-YYYY				
	N	- -					
	O	- -					
	P	- -					
	Q	- -					
	R	- -					
	S	- -					
	T	- -					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.